Electronic structure and imaging contrast of graphene moiré on metals

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Realization of graphene moiré superstructures on the surface of 4d and 5d transition metals offers templates with periodically modulated electron density, which is responsible for a number of fascinating effects, including the formation of quantum dots and the site selective adsorption of organic molecules or metal clusters on graphene. Here, applying the combination of scanning probe microscopy/spectroscopy and the density functional theory calculations, we gain a profound insight into the electronic and topographic contributions to the imaging contrast of the epitaxial graphene/Ir(111) system. We show directly that in STM imaging the electronic contribution is prevailing compared to the topographic one. In the force microscopy and spectroscopy experiments we observe a variation of the interaction strength between the tip and high-symmetry places within the graphene moiré supercell, which determine the adsorption sites for molecules or metal clusters on graphene/Ir(111).

Graphene layers on metal surfaces have been attracting the attention of scientists since several decades, starting from middle of the 60s, when the catalytic properties of the close-packed surfaces of transition metals were in the focus of the surface science research^{1–4}. The demonstration of the fascinating electronic properties of the free-standing graphene^{5,6} renewed the interest in the graphene/metal systems, which are considered as the main and the most perspective way for the large-scale preparation of high-quality graphene layers with controllable properties^{7–10}. For this purpose single-crystalline as well as polycrystalline substrates of 3d – 5d metals can be used.

One of the particularly exciting questions concerning the graphene/metal interface is the origin of the bonding mechanism in such systems^{2–4,11}. This graphene-metal puzzle is valid for both cases: graphene adsorption on metallic surfaces as well as for the opposite situation of the metal deposition on the free-standing or substrate-supported graphene. In the later case the close-packed surfaces of 4d and 5d metals are often used as substrates^{12–14}. A graphene layer prepared on such surfaces, i. e. Ru(0001)^{15–17}, Rh(111)^{14,18,19}, Ir(111)^{20–24}, or Pt(111)^{25,26}, forms so-called moiré structures due to the relatively large lattice mismatch between graphene and metal substrates. As a consequence of the lattice mismatch the interaction strength between graphene and the metallic substrate is spatially modulated leading to the spatially periodic electronic structure. Such lateral graphene superlattices are known to exhibit selective adsorption for organic molecules²⁷ or metal clusters²⁸. Especially, the adsorption of different metals - Ir, Ru, Au, or Pt - on graphene/Ir(111) has been intensively studied showing a preferential nucleation around the so-called FCC or HCP high-symmetry positions within the moiré unit cell^{13,29}. In the subsequent works^{29,30} this site-selective adsorption was explained via local sp^2 to sp^3 rehybridization of carbon atoms with the bond formation between graphene and the cluster. However, a fully consistent description of the local electronic structure of graphene/Ir(111), the observed imaging contrast in scanning probe experiments and the bonding mechanism of molecules or clusters on it is still lacking, motivating the present research.

Here we present the systematic studies of the graphene/Ir(111) system by means of density functional theory (DFT) calculations and scanning tunnelling and atomic force microscopy (STM and AFM) performed in constant current/constant frequency shift (CC/CFS) and constant height (CH) modes. The obtained results for the graphene/Ir(111) system allow to separate the topographic and electronic contributions in the imaging contrast in STM and AFM as well as to shed light on the spatially modulated interaction between graphene/Ir(111) and the metallic STM/AFM tip, which is of paramount importance for the understanding of absorption of metals on top of graphene/Ir(111) as well as of similar graphene-metal systems.

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Results

The unit cell of graphene on Ir(111) is shown in Fig. 1(a) with the corresponding high-symmetry local arrangements of carbon atoms above Ir layers marked in the figure: *ATOP* (circles), *FCC* (squares), *HCP* (down-triangles), and *BRIDGE* (stars). The DFT-D2 optimized local distances between graphene and Ir(111) are 3.27 Å (*HCP*), 3.28 Å (*FCC*), 3.315 Å (*BRIDGE*), 3.58 Å (*ATOP*). This result is very close to the recently published equilibrium structure for this system²¹. The similar distances for *HCP*, *FCC*, and *BRIDGE* positions can be related to the fact that in all these cases one of the carbon atoms in the graphene unit cell is placed above Ir(S) atom defining the local interaction strength for the particular high-symmetry position. The obtained distances are very close to those between carbon layers in pure graphite and this was explained by a binding interaction dominated by van der Waals effects between graphene and Ir(111) that is modulated by weak bonding interactions at the *FCC* and *HCP* places and anti-bonding chemical interaction around *ATOP* positions²¹. As a result a small charge transfer from the graphene π states on Ir empty valence band states is detected in calculations and the Dirac point is shifted by ≈ 100 meV above the Fermi level (E_F) that is close to the data obtained by photoelectron spectroscopy³¹ [see Fig. 2(c) and discussion below].

The graphene/Ir(111) system is a nice example of the moiré structure^{32–37}, which is easily recognisable in LEED and on the large scale STM images shown in Fig. 1(b). The extracted lattice parameter of this structure from LEED and STM is 25.5 Å and 25.2 Å, respectively, that is in good agreement with previously published data³². In most cases, for the typical bias voltages used in STM imaging, the graphene/Ir(111) structure is imaged in the so-called *inverted contrast* [Fig. 1(c,d)]³², when topographically highest *ATOP* places are imaged as dark and topographically lowest *FCC* and *HCP* ones as bright regions. This assignment was initially done in Ref. [32], where the STM topography of neighbouring regions of the clean and graphene-covered Ir(111) surface were imaged. In our studies we perform the “on-the-fly” switching between CC STM and CFS AFM imaging during scanning [Fig. 1(d)] where we observe the inversion of the topographic contrast $z(x, y)$ (see also Fig. S1 of the supplementary material). This becomes clearly evident around areas marked by arrows in Fig. 1(d) where the darkest contrast in CC STM becomes the brightest one in CFS AFM for the *ATOP* position. In the later case the darkest areas correspond to *HCP* sites that correlates with the calculated height changes between lowest and highest carbon positions. The pronounced difference between the *FCC* and *HCP* areas can be explained by fact that additional bias voltage was applied in order to increase the atomically-resolved contrast. The present result is opposite to the observations published earlier in Ref. [37] and where no contrast inversion between STM and AFM was observed. Our further analysis demonstrates that the imaging contrast strongly depends on the experimental conditions (tunnelling bias and current, frequency shift, distance from the sample), but performed switch “on the fly” between STM and AFM demonstrates the possibility to directly trace the changes between STM and AFM pictures.

The inversion of the imaging contrast was also detected in CC STM images when the bias voltage is changed from -0.5 V to -1.8 V during scanning [Fig. 2(a)]. The images taken at positive voltages are similar to the lower part of the figure Fig. 2(a) (see Fig. S2 of the supplementary material). The simulations of STM images using the experimental conditions show very good agreement with the obtained data [Fig. 2(a,b) and Fig. S2]. The presented STM results demonstrate the big difference in the local electronic structure for high-symmetry positions of carbon atoms on Ir(111). That can point out on the difference in the local adsorption strength for these places.

In order to prove this assertion we have performed the force microscopy and spectroscopy experiments on graphene/Ir(111). Fig. 3 shows (a,b) the frequency shift of an oscillating scanning sensor

Figure 1 | (a) Crystallographic structure of (10×10) graphene on (9×9) Ir(111). The high-symmetry places are marked by circle, rectangle, down-triangle, and stars for *ATOP*, *FCC*, *HCP*, and *BRIDGE* positions. (b) Large scale (162×55 nm²) STM image of graphene/Ir(111). The inset shows the corresponding LEED image obtained at 71 eV. (c) Atomically resolved STM image of graphene/Ir(111) showing the *inverted contrast*. (d) A combined STM/AFM image with a switching “on-the-fly” between CC STM and CFS AFM imaging during scanning. The scan sizes are 5.2×5.2 nm² ($U_T = +550$ meV, $I_T = 540$ pA) and 10×10 nm² (STM: $U_T = +461$ meV, $I_T = 7.6$ nA, AFM: $\Delta f = -675$ mHz) for (c) and (d), respectively.

as a function of a distance from the sample, $\Delta f(d)$, and (c) the corresponding tunnelling current, $I(d)$, measured in the unit cell of graphene/Ir(111) along the path marked in the CC STM image shown as an inset of (a). During these measurements the tunnelling current was used for the stabilisation of the feedback loop, allowing to determine the relative z -position of the Δf and I curves. Following the sequence: $F_z(d) = -\partial E(d)/\partial d$, $\Delta f(d) = -f_0/2k_0 \cdot \partial F_z(d)/\partial d$, where $E(d)$ and $F_z(d)$ are the interaction energy and the vertical force between a tip and the sample, respectively, f_0 and k_0 are the resonance frequency and the spring constant of the sensor, correspondingly, we can separate repulsive, attractive, and long-range electrostatic and van der Waals contributions in AFM imaging. The imaging contrast at distances more than 5 Å from the surface is defined by long-range van der Waals interactions which are insensitive to the atomically resolved structure of the scanning tip and the sample. The short-range chemical interactions around the minimum of the Δf curve are dominated either by repulsive (left-hand side) or attractive (right-hand side) forces and give the atomically-resolved site-selective chemical contrast.

Figure 2 | Experimental ($I_T = 15$ nA) (a) and calculated (b) CC STM images of graphene/Ir(111) obtained at -0.5 V (bottom) and -1.8 V (top) of the bias voltage. (c) Carbon-site projected density of states calculated for all high-symmetry places of graphene/Ir(111) (zoom around E_F is shown as an upper inset). Difference electron density, $\Delta\rho(r) = \rho_{gr/Ir(111)}(r) - \rho_{Ir}(r) - \rho_{gr}(r)$, plotted in units of $e/\text{\AA}^3$ is shown as lower inset.

The presented $\Delta f(d)$ curves [Fig. 3(a,b)] clearly show the site-selective interaction in the unit cell of the graphene/Ir(111) system. First of all, the absolute value of the maximal frequency shift is higher for the FCC and HCP areas compared to ATOP ones indicating the stronger interaction of graphene with the tungsten STM/AFM tip for the former carbon positions. We would like to note, that the same trend will be observed for the adsorption of metal atoms or clusters on graphene/Ir(111). Secondly, the difference in the positions of $\Delta f(d)$ -curve minima is 0.097 nm [Fig. 3(b)] compared to the value of graphene corrugation of 0.067 nm obtained from the CC STM image [inset of Fig. 3(a)], also pointing on the difference in the interaction strength for two carbon positions, ATOP and FCC.

The measured $\Delta f(d)$ curves were used to track and explain the contrast obtained in CH AFM experiments (Fig. 4 and Fig. S4 in supplementary material). In this experiments the z -coordinate of the oscillating sensor was fixed during scanning and $\Delta f(x, y)$ and $I(x, y)$ maps were collected. As can be clearly seen from the presented results the imaging contrast in CH Δf images is changing as a function of z -coordinate and it is fully inverted for two limit z -positions [$d_1 = -0.033$ nm and $d_2 = +0.227$ nm, see Fig. 3(b)] used for the imaging (upper row in Fig. 4). In the region of distances between the tip and the graphene/Ir(111) sample, where chemical forces determine the interaction, on the right-hand side of the Δf curve the interaction is attractive giving the more negative frequency shift for the ATOP positions as located closer to the oscillating tip compared to the FCC and HCP areas. On the other side, on the left-hand

side of the curve the repulsive interaction starts to contribute in the interaction giving the smaller frequency shift for ATOP compared to other positions that can again be explained by the different distances between tip and the sample for different high-symmetry positions as well as by the different interaction strength at these places. At the same time the contrast for the current map $I(x, y)$ is always the same, *inverted contrast* (lower row in Fig. 4). Taking into account that during CH imaging at $+50$ meV in Fig. 4 the imaging contrast for $I(x, y)$ is *inverted* due to the higher DOS for the FCC and HCP positions and that variation of the distance for CH imaging and CC STM imaging (when U_T is changed from -0.5 V to -1.8 V) is nearly the same (see next section for discussion of STM simulations), one can separate the topographic and electronic contributions into imaging at different biases and distances.

Here we would also like to note that the change of the bias voltage during CH AFM imaging does not lead to any changes in the imaging contrast for Δf (Fig. 5). The first row shows the two small-scanning range atomically resolved $\Delta f(x, y)$ images acquired on the same place of the graphene/Ir(111) sample with opposite signs for the bias voltage: the imaging contrast is the same with the slight variation of the imaging scale that can be explained by the small drift of the oscillating tip. The first look on the $I(x, y)$ map (lower row) might give an impression that the contrast is fully inverted. However, the absolute value of the tunnelling current is the same and only more negative values of the tunnelling current are shown as darker areas in the image for current.

Figure 3 | Frequency shift (a,b) of the oscillating KolibriSensor and the corresponding tunnelling current (c) as a function of the relative distance d between tip and the graphene/Ir(111) sample. These curves were acquired with respect to the set-point for the CC STM imaging. Inset of (a) shows the corresponding STM image ($U_T = +50$ mV, $I_T = 400$ pA) with the path where Δf and I data were measured.

Discussion

The graphene/Ir(111) system was studied with DFT methods in order to deeply understand the effects of the electronic structure on the adsorption properties of this system. Here we present the comparison between experimental and theoretical STM data. The STM images are calculated using the Tersoff-Hamann formalism³⁸, in its most basic formulation, approximating the STM tip by an infinitely small point source^{19,39,40}. In these simulations the constant current condition was fulfilled that leads to the increasing of the distance between the sample and a tip from 2.50 Å for $U_T = -0.5$ V to 3.21 Å for $U_T = -1.8$ V [Fig. 2(b)]. Taking into account

that at negative bias voltages the electrons tunnel from occupied states of the sample into unoccupied states of the tip and that tunnelling current is proportional to the surface local density of states (LDOS) at the position of the tip we can clearly identify the states in the valence band of graphene/Ir(111) which are responsible for the formation of the imaging contrast (see Fig. S3 of the supplementary material for the identification of the local valence band states). [The surface Brillouin zone (BZ) of the graphene/Ir(111) system is approximately 10 times smaller compared to BZ of free-standing graphene giving the maximal wave-vector of electrons of $k_{||} \approx 0.17$ Å⁻¹ for the K-point, i. e. in this case one has to consider a small region

Figure 4 | Constant height images of graphene/Ir(111), $\Delta f(x, y)$ (upper row) and $I(x, y)$ (lower row), obtained at two different heights d_1 and d_2 of the KolibriSensor above the surface (see Fig. 3). The size of the scanning area is 10.5×10.5 nm².

Figure 5 | Atomically-resolved constant height images of graphene/Ir(111), $\Delta f(x, y)$ (upper row) and $I(x, y)$ (lower row), collected at opposite signs of bias voltages. The size of the scanning area is $4.3 \times 4.3 \text{ nm}^2$.

in the reciprocal space around the Γ -point. In this case we can assign the features in the tunnelling current as originating from the corresponding peaks in DOS of the whole system (in general, the tunnelling current depends on the $k_{\parallel}$ of electronic states participating in the tunnelling process and the electronic states with a large parallel component of the wave vector give a small contribution to the current). Therefore, the so-called *inverted contrast* for the small bias voltages, negative or positive, can be explained by two features in LDOS for the carbon atoms in the FCC position located at $E - E_F = -0.53 \text{ eV}$ and $E - E_F = +0.32 \text{ eV}$, respectively [Fig. 2(c)]. The next two maxima in LDOS for C *ATOP* positions located at $E - E_F = -0.95 \text{ eV}$ and $E - E_F = -1.49 \text{ eV}$ [Fig. 2(c)] explain the fact that these high-symmetry places become brighter for higher bias voltages in experimental and simulated CC STM images [Fig. 2(a,b)].

The calculated LDOS for graphene/Ir(111) compared with DOS for the free-standing graphene [(10×10) unit cell] are shown in Fig. 2(c) together with the electron density difference distribution presented as lower inset. The obtained DOS results demonstrate the slight difference in the position of main features (π -states at $E - E_F \approx 6.1 \text{ eV}$, σ -states at $E - E_F \approx 3.2 \text{ eV}$, and the *M*-point-derived Kohn anomaly at $E - E_F \approx 2.2 \text{ eV}$) as well as the Dirac cone between two systems, that is assigned to the *p*-doping of graphene on Ir(111). The DOS features responsible for the formation of the STM contrast can be considered as a result of the hybridisation between graphene π states and the valence band states of Ir around the particular high-symmetry adsorption positions (see Fig. S3 of the supplementary material for the identification of the local valence band states). The trace of this hybrid states can be identified in the full photoemission map of the graphene/Ir(111) system presented in Ref. [11]: the calculated DOS peaks can be identified as weak “flat” hybrid bands in experimental band structure along the $K - M$ direction. However, as was discussed earlier the folding of the bands leads to the fact that these bands will appear around the Γ point and can effectively contribute to the tunnelling and can be responsible for the contrast inversion observed in the experiment. Here we would like to note, that one can also consider the increased LDOS around E_F for FCC, HCP, and BRIDGE positions as a hint indicating that these places can be nucleation centers for adsorbed atoms^{12,13}.

In order to get better insight in the results obtained during our AFM experiments (Figs. 3, 4, 5) we performed simulations of these

data in the framework of DFT formalism (we would like to note that a qualitative description of the buckled graphene systems was performed in Ref. [41], where the model Lennard-Jones potential was used to model tip-sample interaction). Due to the large size of the unit cell of the graphene/Ir(111) system we employed two approaches. In the first one, which requires less computational resources, the tip-sample force is expressed as a function of the potential $V_{ts}(\mathbf{r})$ on the tip due to the sample: $F_{ts} \propto -\nabla[V_{ts}(\mathbf{r})]^2$ ⁴². However, this method does not take into account the geometrical and electronic structure of the scanning tip and thereby does not allow to get absolute values for the force or frequency shift and the correct distance between the tip and the sample, and only qualitative result for the attractive region of the interaction can be obtained. The result of such simulations for graphene/Ir(111) is shown in Fig. 6(a), which is in rather good agreement with experimental data: the regions around *ATOP* positions are imaged as dark compared to other high-symmetry sites imaged as brighter contrast. Unfortunately, the information about repulsive region of the forces cannot be obtained from such calculations. However, if the model corrugation-dependent repulsive potential is added, then the resulting simulated Δf curve reproduces qualitatively the experimentally obtained results.

For the purpose to reproduce our data in a more quantitative way, the interaction between the tip and the graphene/Ir(111) system was simulated within the second approach, where *W*-tip is approximated by the 5-atom pyramid as shown in Fig. 6(b). The results of these calculations are compiled in Fig. 6(c–e). The interaction energy (system was rigid without allowing to relax) between model *W*-tip and the surface was calculated for two limiting places of graphene/Ir(111), *ATOP* and FCC. The calculated points are shown by filled rectangles and circles in Fig. 6(c) for the FCC and *ATOP* positions, respectively. The Morse potential was used to fit the calculated data as the most suitable for the graphene-metal systems^{43,44}. The resulting curves are shown by solid lines in the same figure. The force and the frequency shift curves were calculated on the basis of the obtained interaction energy curves according to formulas presented earlier. The results are shown in Fig. 6(d) and (e), respectively.

The interaction energy curves [Fig. 6(c)] are very similar for the two high-symmetry areas and shifted with respect to each other by $0.40 \text{ \AA}$ reflecting the height difference between *ATOP* and FCC

Figure 6 | (a) Simulated CH AFM image of the graphene/Ir(111) system according to the approach suggested in Ref. [42]. (b) Schematic representation of the geometry of the 5-atom-W-tip/graphene/Ir(111) system used in simulation of the frequency shift curves. Interaction energy (c) and the force (d) between 5-atom W-tip and graphene/Ir(111) calculated for two limit places *ATOP* and *FCC*. (e) Frequency shift as a function of distance between the model 5-atom-W-tip and graphene/Ir(111).

regions. The maximal absolute value of energy is slightly higher for *FCC* by 0.015 eV. However, our calculations do not take into account the relaxation of the system during the tip-sample interaction. Therefore the actual values can be different. Calculation of the force and the frequency shift via derivation of the respective curves leads to the clear discrimination in the value of the extrema as well as to the further separation of their positions and for the Δf curves the extrema are separated by 0.45 Å. The resulting values for the frequency shift for our model W-tip are approximately 2 times larger compared to experimental values. Nevertheless, the shape and the trend for the inversion of the imaging contrast are clearly reproducible in our calculated data. The following reasons can explain the difference between experiment and theory: (i) small W-cluster modelling the actual W-tip, (ii) system was not relaxed during calculations, (iii) the actual atomic structure of the tip during experiment is unknown, (iv) small uncertainty in the tip position during measurements of Δf curves. However, in spite of these simplifications⁴⁵, the presented calculation results allow us to confirm and better understand the data obtained during the AFM measurements.

In conclusion, we performed the systematic investigations of the geometry, electronic structure and their effects on the observed imaging contrast during STM and AFM experiments on graphene/Ir(111). Our results obtained via combination of DFT calculations and scanning probe microscopy imaging allow to discriminate the topographic and electronic contributions in these measurements and to explain the observed contrast features. We found that in STM imaging the electronic contribution is prevailing compared to the topographic one and the inversion of the contrast can be assigned to the particular features in the electronic structure of graphene on Ir(111). Contrast changes observed in constant height AFM measurements are analyzed on the basis of the energy, force, and frequency shift curves reflecting the interaction of the W-tip with the

surface and are attributed to the difference in the height and the different interaction strength for high-symmetry sites within the moiré unit cell of graphene on Ir(111). The presented findings are of general importance for the understanding of the properties of the lattice-mismatched graphene/metal systems especially with regard to possible applications as templates for molecules or clusters.

Note added after submission. During consideration of the present manuscript similar AFM results on graphene/Ir(111) were published in Ref. [46].

Methods

DFT calculations. The crystallographic model of graphene/Ir(111) presented in Fig. 1(a) was used in DFT calculations, which were carried out using the projector augmented plane wave method⁴⁷, a plane wave basis set with a maximum kinetic energy of 400 eV and the PBE exchange-correlation potential⁴⁸, as implemented in the VASP program⁴⁹. The long-range van der Waals interactions were accounted for by means of a semiempirical DFT-D2 approach proposed by Grimme⁵⁰. The studied system is modelled using supercell, which has a (9×9) lateral periodicity and contains one layer of (10×10) graphene on a four-layer slab of metal atoms. Metallic slab replicas are separated by ca. 20 Å in the surface normal direction. To avoid interactions between periodic images of the slab, a dipole correction is applied⁵¹. The surface Brillouin zone is sampled with a $(3 \times 3 \times 1)$ k -point mesh centered the Γ point.

STM and AFM experiments. The STM and AFM measurements were performed in two different modes: constant current (CC) or constant frequency shift (CFS) and constant height (CH). In the first case the topography of sample, $z(x, y)$, is studied with the corresponding signal, tunnelling current (I_T) or frequency shift (Δf), used as an input for the feedback loop. In the latter case the z -coordinate of the scanning tip is fixed with a feedback loop switched off that leads to the variation of the distance d between tip and sample. In such experiments $I_T(x, y)$ and $\Delta f(x, y)$ are measured for different z -coordinates. The STM/AFM images were collected with SPM Aarhus 150 equipped with KolibriSensorTM from SPECS^{19,52} with Nanonis Control system. In all measurements the sharp W-tip was used which was cleaned *in situ* via Ar⁺-sputtering. In presented STM images the tunnelling bias voltage, U_T , is referenced to

the sample and the tunnelling current, I_T , is collected by the tip, which is virtually grounded. During the AFM measurements the sensor was oscillating with the resonance frequency of $f_0 = 999161$ Hz and the quality factor of $Q = 45249$. The oscillation amplitude was set to $A = 100$ pm or $A = 300$ pm.

Preparation of graphene/Ir(111). The graphene/Ir(111) system was prepared in ultrahigh vacuum station for STM/AFM studies according to the recipe described in details in Ref. [32] via cracking of ethylene: $T = 1100^\circ\text{C}$, $p = 5 \times 10^{-8}$ mbar, $t = 15$ min. This procedure leads to the single-domain graphene layer on Ir(111) of very high quality that was verified by means of low-energy electron diffraction (LEED) and STM. The base vacuum was better than 8×10^{-11} mbar during all experiments. All measurements were performed at room temperature.

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Author contributions

Y.S.D. conducted and analysed the experiments. E.V. and E.F. performed DFT calculations. E.V. analysed the DFT data. A.G., F.M., M.F. and A.T. contributed in the discussion of the experimental and theoretical results. Y.S.D. directed the research and wrote the manuscript. All authors edited and commented on the manuscript.

Additional information

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